承認書 SPECIFICATION FOR APPROVAL

客户名稱 CUSTOMER	:	
客户料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	WAN3216F245W36
規格 DESCRIPTION	:	Chip Antenna 3216 M-Ant 2.45G Type 36
版本 VERSION	:	V1.0
日期 ISSUE DATE	:	2016/05/23



	工 程 部 R&D CENTER	
承 認 APPROVAL	確認 CHECKED	製 作 DRAWN
Ray	James	Thor



萬誠科技股份有限公司

112 台北市北投區中央南路二段 36 號 3 樓

電話: (02) 2898-2220 傳真: (02) 2898-5055

OneWave Electronic Co., Ltd.

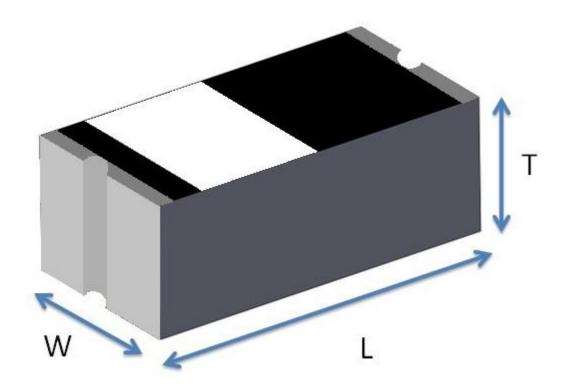
2F., No.163, Sec. 1, Xi'an St., Beitou Dist., Taipei City 112, Taiwan

TEL: +886 2 2898-2220 FAX: +886 2 2898-5055



3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245W36

	Dimension (mm)			
L	3.23 ± 0.20			
W	1.66 ± 0.20			
Т	1.23 ± 0.20			

Part Number Information

WAN	<u>3216</u>	E	<u>245</u>	W	<u>36</u>
Α	В	С	D	Е	F

Α	Product Series	Antenna		
В	Dimension L x W	3.2X1.6mm (+-0.2mm)		
С	Material	High K material		
D	Working Frequency	2.4 ~ 2.5GHz		
Ε	Feeding mode	Monopole & Single Feeding		
F	Antenna type	Type=36		

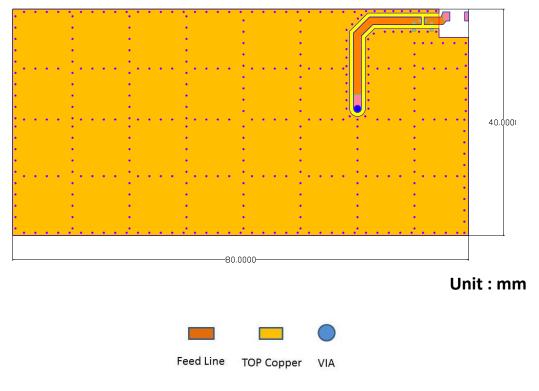
1. Electrical Specification

Specification					
Part Number	WAN3216F245W36				
Central Frequency	2450	MHz			
Bandwidth	100 (Min.)	MHz			
Return Loss	-6.5 (Max)	dB			
Peak Gain	2.71	dBi			
Impedance	50	Ohm			
Operating Temperature	-40~+85	°C			
Maximum Power	4	W			
Resistance to Soldering Heats	10 (@ 260°C)	sec.			
Polarization	Linear				
Azimuth Beamwidth	Omni-directional				
Termination	Cu / Sn (Leadless)				

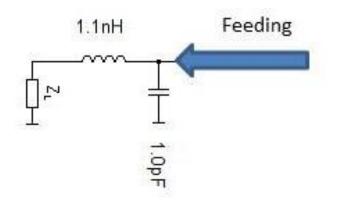
Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

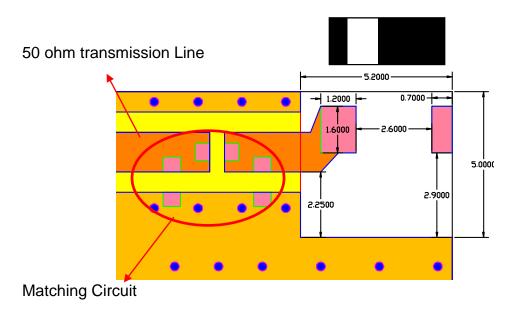
2. Recommended PCB Pattern

Evaluation Board Dimension



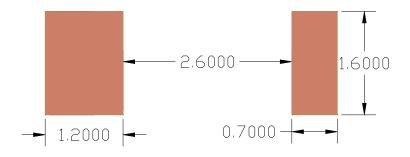
Suggested Matching Circuit





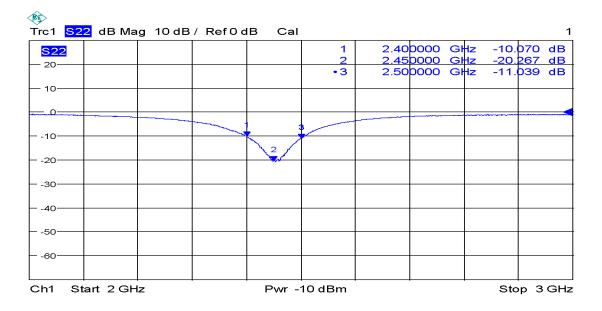
Layout Dimensions in Clearance area(Size=5.2*5.0mm)

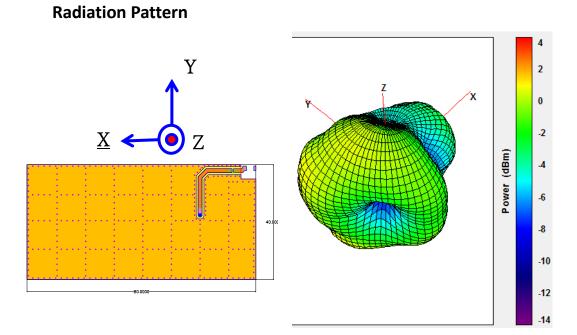




3. Measurement Results

Return Loss

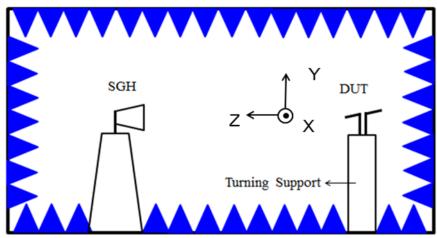




	Efficiency	Peak Gain	Directivity
2400MHz	55.21 %	1.45 dBi	5.32 dBi
2450MHz	66.45 %	2.71 dBi	5.21 dBi
2500MHz	57.53 %	1.98 dBi	5.29 dBi

Chamber Coordinate System





4. Reliability and Test Condictions

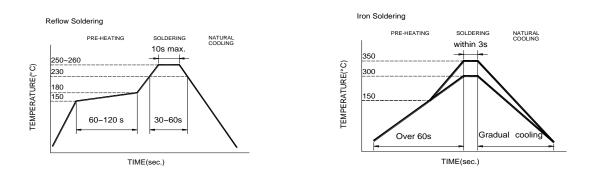
ITEM	REQUIREMENTS	TEST CONDITION
Solderability	1. Wetting shall exceed 90% coverage 2. No visible mechanical damage TEMP (°C) 230°C 150°C 60sec	Pre-heating temperature:150°C /60sec. Solder temperature:230±5°C Duration:4±1sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin
Solder heat Resistance	1. No visible mechanical damage 2. Central Freq. change :within $\pm 6\%$ TEMP (°C) 260°C 150°C 60sec	Pre-heating temperature:150°C /60sec. Solder temperature:260±5°C Duration:10±0.5sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin
Component Adhesion (Push test)	1. No visible mechanical damage	The device should be reflow soldered(230±5°C for 10sec.) to a tinned copper substrate A dynometer force gauge should be applied the side of the component. The device must with-ST-F 0.5 Kg without failure of the termination attached to component.
Component Adhesion (Pull test)	1. No visible mechanical damage	Insert 10cm wire into the remaining open eye bend ,the ends of even wire lengths upward and wind together. Terminal shall not be remarkably damaged.



Thermal shock		ole mechanical dama Freq. change :withi	0	+85℃=>30±3min -40℃=>30±3min
	Phase	Temperature(℃)	Time(min)	Test cycle:10 cycles
	1	+85±5 ℃	30±3	The chip shall be stabilized at normal condition for 2~3 hours before
	2	Room Temperature	Within 3sec	measuring.
	3	-40±2 ℃	30±3	
	4	Room Temperature	Within 3sec	
Resistance to High	2. Central Freq. change :within ±6%			Temperature: 85±5℃ Duration: 1000+12hrs
Temperature				The chip shall be stabilized at normal condition for 2~3 hours before
Resistance to Low Temperature	 No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit. 			measuring. Temperature:-40±5℃ Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.
Humidity	 No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit. 		n ±6%	Temperature: 40±2℃ Humidity: 90% to 95% RH Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.

5.Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



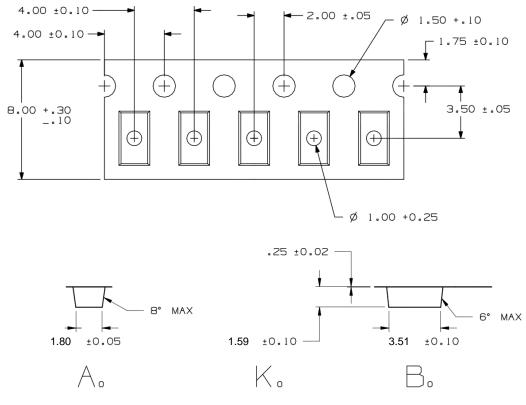
Recommended temperature profiles for re-flow soldering in Figure 1.

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150° C
- · Never contact the ceramic with the iron tip
- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280° C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

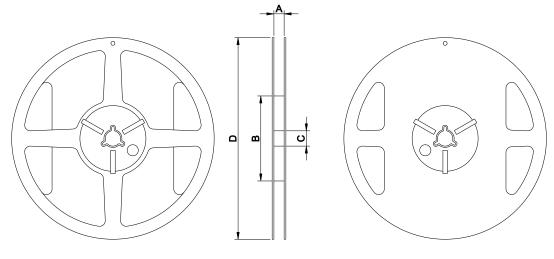
6.Packaging Information

• Tape Specification:



Reel Specification: (7", Φ180 mm)

<mark>onew</mark>ave



7" x 8 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000

7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40 $^\circ \! \mathbb{C}$ and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.